



High-reliability discrete products  
and engineering services since 1977

# 2N6306-2N6308

## SILICON NPN TRANSISTORS

### FEATURES

- Available as "HR" (high reliability) screened per MIL-PRF-19500, JANTX level. Add "HR" suffix to base part number.
- Available as non-RoHS (Sn/Pb plating), standard, and as RoHS by adding "-PBF" suffix.

### MAXIMUM RATINGS

Parameter	Symbol	2N6306	2N6307	2N6308	Unit
Collector-base voltage	V <sub>CBO</sub>	500	600	700	V
Collector-emitter voltage	V <sub>CEO</sub>	250	300	350	V
Emitter-base voltage	V <sub>EBO</sub>		8		V
Collector current – continuous	I <sub>C</sub>		8		A
Collector current – peak	I <sub>CM</sub>		16		A
Base current	I <sub>B</sub>		4.0		A
Total power dissipation Derate above T <sub>C</sub> = 25°C	P <sub>D</sub>		125 0.714		W W/°C
Junction and storage temperature range	T <sub>J</sub> , T <sub>stg</sub>		-65 to 200		°C
Thermal resistance, junction to case	R <sub>θJC</sub>		1.4		°C/W

### ELECTRICAL CHARACTERISTICS (T<sub>C</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Conditions	2N6306		2N6307		2N6308		Unit
			Min	Max	Min	Max	Min	Max	
Collector-emitter sustaining voltage	V <sub>CEO(sus)</sub>	I <sub>C</sub> = 100mA, I <sub>B</sub> = 0	250	-	300	-	350	-	V
Collector cutoff current	I <sub>CEO</sub>	V <sub>CE</sub> = Rated V <sub>CEO</sub> , I <sub>B</sub> = 0	-	0.5	-	0.5	-	0.5	mA
Collector cutoff current	I <sub>CEx</sub>	V <sub>CE</sub> = 500V, V <sub>EB(off)</sub> = 1.5V	-	0.5	-	0.5	-	0.5	mA
		V <sub>CE</sub> = 600V, V <sub>EB(off)</sub> = 1.5V	-	-	-	-	-	-	
		V <sub>CE</sub> = 700V, V <sub>EB(off)</sub> = 1.5V	-	-	-	-	-	-	
		V <sub>CE</sub> = 450V, V <sub>EB(off)</sub> = 1.5V, T <sub>C</sub> = 150°C	-	2.5	-	2.5	-	2.5	
		V <sub>CE</sub> = 550V, V <sub>EB(off)</sub> = 1.5V, T <sub>C</sub> = 150°C	-	-	-	-	-	-	
		V <sub>CE</sub> = 650V, V <sub>EB(off)</sub> = 1.5V, T <sub>C</sub> = 150°C	-	-	-	-	-	-	
Emitter cutoff current	I <sub>EBO</sub>	V <sub>EB</sub> = 8V, I <sub>C</sub> = 0	-	1.0	-	1.0	-	1.0	mA
DC current gain <sup>(1)</sup>	h <sub>FE</sub>	I <sub>C</sub> = 3.0A, V <sub>CE</sub> = 5V I <sub>C</sub> = 8A, V <sub>CE</sub> = 5V	15 4.0	75 -	15 4.0	75 -	12 3.0	60 -	-
Collector-emitter saturation voltage <sup>(2)</sup>	V <sub>CE(sat)</sub>	I <sub>C</sub> = 3.0A, I <sub>B</sub> = 0.6A I <sub>C</sub> = 8.0A, I <sub>B</sub> = 2.0A I <sub>C</sub> = 8.0A, I <sub>B</sub> = 2.67A	-	0.9 5.0 -	-	1.0 5.0 -	-	1.5 -	V
Base-emitter saturation voltage <sup>(2)</sup>	V <sub>BE(sat)</sub>	I <sub>C</sub> = 8.0A, I <sub>B</sub> = 2.0A I <sub>C</sub> = 8.0A, I <sub>B</sub> = 2.67A	-	2.3 -	-	2.3 -	-	2.5 -	V
Base emitter on voltage <sup>(4)</sup>	V <sub>BE(on)</sub>	I <sub>C</sub> = 3.0A, V <sub>CE</sub> = 5.0A	-	1.3	-	1.3	-	1.5	V
Second breakdown energy	E <sub>s/b</sub>	I <sub>C(PK)</sub> = 3.0A, L = 40mH, R <sub>BE</sub> = 3kΩ, V <sub>BB2</sub> = 1.5V	-	180	-	180	-	180	mJ
Current gain – bandwidth product <sup>(2)</sup>	f <sub>T</sub>	I <sub>C</sub> = 0.3A, V <sub>CE</sub> = 10V, f <sub>test</sub> = 1.0MHz	5.0	-	5.0	-	5.0	-	mA

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Parameter	Symbol	Conditions	2N6306		2N6307		2N6308		Unit
			Min	Max	Min	Max	Min	Max	
<b>Output capacitance</b>	C <sub>ob</sub>	V <sub>CB</sub> = 10V, I <sub>B</sub> = 0, f = 0.1MHz	250	-	300	-	350	-	V
<b>Rise time</b>	t <sub>r</sub>	V <sub>CC</sub> = 125V, I <sub>C</sub> = 3.0A, I <sub>B</sub> = 0.5A	-	0.6	-	0.6	-	0.6	μs
<b>Storage time</b> <sup>(3)</sup>	t <sub>s</sub>	V <sub>CC</sub> = 125V, I <sub>C</sub> = 3.0A, I <sub>B1</sub> = 0.6A, I <sub>B2</sub> = 1.5 Pulse width = 25μs Pulse width = 5.0μs	-	1.6	-	1.6	-	1.6	μs
<b>Fall time</b>	t <sub>f</sub>	V <sub>CC</sub> = 125V, I <sub>C</sub> = 3.0A, I <sub>B1</sub> = 0.6A, I <sub>B2</sub> = 1.5	-	0.4	-	0.4	-	0.4	μs

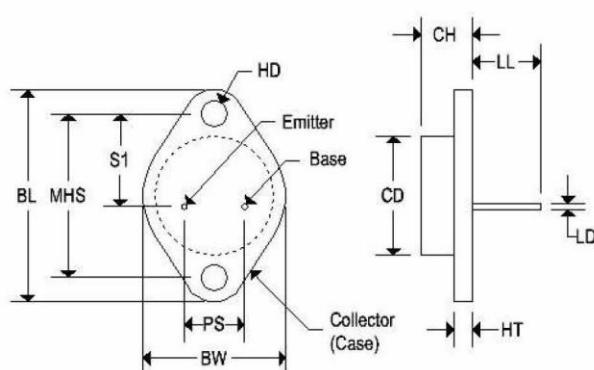
Note 1: Pulse test: pulse width ≤ 300μs. Duty cycle = 2.0%

Note 2: fT = I<sub>hfel</sub> \* f<sub>test</sub>

Note 3: "On" time is 25°C. t<sub>s</sub> decreases with shorter pulse width being approximately 50% of the values shown at a 5.0μs pulse width.

### MECHANICAL CHARACTERISTICS

<b>Case:</b>	TO-3
<b>Marking:</b>	Alpha-Numeric
<b>Polarity:</b>	See below



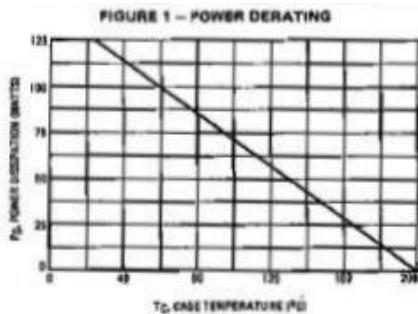
	TO-3			
	Inches		Millimeters	
	Min	Max	Min	Max
CD	-	0.875	-	22.220
CH	0.250	0.380	6.860	9.650
HT	0.060	0.135	1.520	3.430
BW	-	1.050	-	26.670
HD	0.131	0.188	3.330	4.780
LD	0.038	0.043	0.970	1.090
LL	0.312	0.500	7.920	12.700
BL	1.550 REF		39.370 REF	
MHS	1.177	1.197	29.900	30.400
PS	0.420	0.440	10.670	11.180
S1	0.655	0.675	16.640	17.150



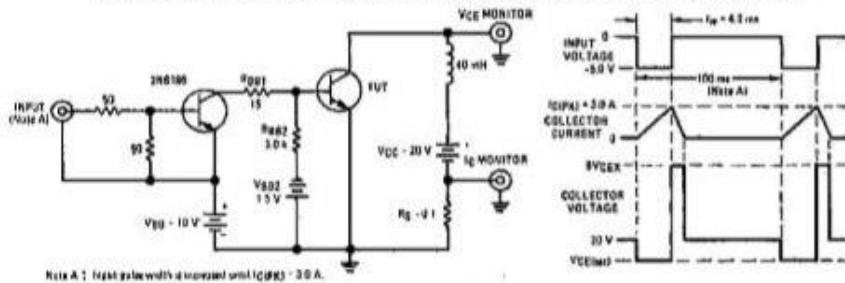
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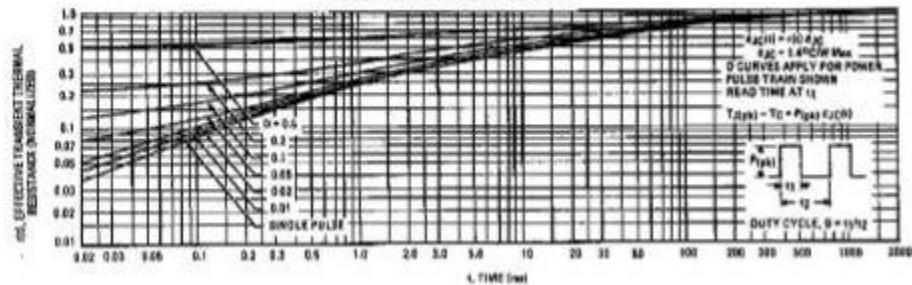
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**FIGURE 2 – SECOND BREAKDOWN ENERGY TEST CIRCUIT AND WAVEFORMS**



**FIGURE 3 – THERMAL RESPONSE**





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ACTIVE REGION SAFE OPERATING AREA

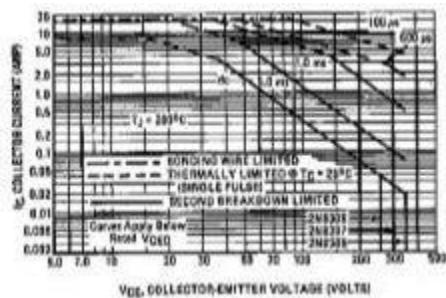


FIGURE 5 -- SWITCHING TIMES TEST CIRCUIT

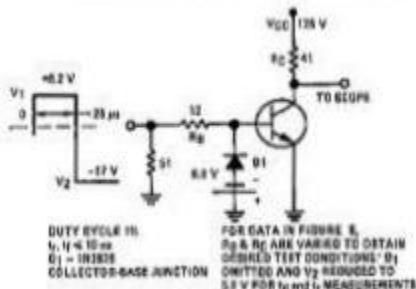


FIGURE 6 -- TURN-ON AND TURN-OFF TIMES

